

Search Notes

Application/Control No.

10/069,516

Examiner

Jacob Meek

Applicant(s)/Patent under
Reexamination

AIKAWA ET AL.

Art Unit

2637

SEARCHED

Class	Subclass	Date	Examiner
375	206,200 347,349 267,150 147,142	8/5/2005	JM
370	335,342	8/5/2005	JM
343	703,725	8/5/2005	JM
455	134,500	8/5/2005	JM
455	504,506	8/5/2005	JM
455	63,65	8/5/2005	JM
375	148	8/5/2005	JM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/5/2005	JM
NPL	8/5/2005	JM